

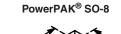
RoHS

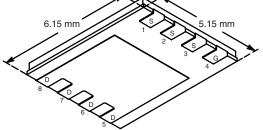
COMPLIANT

Vishay Siliconix

N-Channel 100-V (D-S) MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	R_{DS(on)} (Ω)	R _{DS(on)} (Ω) I _D (A) ^a			
100	0.0078 at V _{GS} = 10 V	60	35.7 nC		
	0.0085 at V_{GS} = 7.5 V	60	55.7 HC		





Bottom View

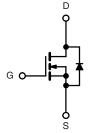
Ordering Information: SiR846DP-T1-GE3 (Lead (Pb)-free and Halogen-free)

FEATURES

- Halogen-free According to IEC 61249-2-21 Definition
- TrenchFET[®] Power MOSFET
- 100 % R_g Tested
- 100 % UIS Tested
- Compliant to RoHS Directive 2002/95/EC

APPLICATIONS

- · Primary Side Switch
- Isolated DC/DC Converters
- Full Bridge



N-Channel MOSFET

ABSOLUTE MAXIMUM RATING	S T _A = 25 °C, unle	ss otherwise not	ed		
Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V _{DS}	100	V	
Gate-Source Voltage		V _{GS}	± 20	v	
	T _C = 25 °C		60 ^a		
Continuous Drain Current ($T_1 = 150 \ ^{\circ}C$)	T _C = 70 °C		60 ^a	7	
Continuous Drain Current $(T_j = 150^{\circ} C)$	T _A = 25 °C	I _D	20 ^{b, c}		
	T _A = 70 °C		16 ^{b, c}	A	
Pulsed Drain Current		I _{DM} 100	100	^	
Continuous Source-Drain Diode Current	T _C = 25 °C	1-	60 ^a		
Continuous Source-Drain Diode Current	T _A = 25 °C	I _S	5.6 ^{b, c}		
Single Pulse Avalanche Current	L _ 0.1 mH	I _{AS}	35		
Single Pulse Avalanche Energy L = 0.1 mH		E _{AS}	61	mJ	
	T _C = 25 °C		104		
Maximum Power Dissipation	T _C = 70 °C	P _D	66.6	w	
	T _A = 25 °C	'D	6.25 ^{b, c}	vv	
	T _A = 70 °C		4.0 ^{b, c}	1	
Operating Junction and Storage Temperature Ra	T _J , T _{stg}	- 55 to 150			
Soldering Recommendations (Peak Temperature) ^{d, e}			260		

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{b, f}	t ≤ 10 s	R _{thJA}	15	20	°C/W	
Maximum Junction-to-Case (Drain)	Steady State	R _{thJC}	0.9	1.2		

Notes:

a. Package limited.

b. Surface Mounted on 1" x 1" FR4 board.

c. t = 10 s.

d. See Solder Profile (<u>www.vishay.com/ppg?73257</u>). The PowerPAK SO-8 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.

e. Rework Conditions: manual soldering with a soldering iron is not recommended for leadless components.

f. Maximum under Steady State conditions is 54 °C/W.

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Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Static					•	
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 V$, $I_{D} = 250 \mu A$	100			V
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = 250 μA		- 6.7		mV/°C
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = 250 \ \mu A$	1.5		3.5	V
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 V, V_{GS} = \pm 20 V$			± 100	nA
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = 100 \text{ V}, V_{GS} = 0 \text{ V}$			1	
		V_{DS} = 100 V, V_{GS} = 0 V, T_{J} = 55 °C			10	μΑ
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	30			Α
Drain-Source On-State Resistance ^a	R _{DS(on)}	$V_{GS} = 10 \text{ V}, I_D = 20 \text{ A}$		0.0064	0.0078	
		$V_{GS} = 7.5 \text{ V}, \text{ I}_{D} = 15 \text{ A}$		0.007	0.0085	Ω
Forward Transconductance ^a	9 _{fs}	V _{DS} = 15 V, I _D = 20 A		56		S
Dynamic ^b	<u> </u>					•
Input Capacitance	C _{iss}			2870		pF
Output Capacitance	C _{oss}	$V_{DS} = 50 \text{ V}, V_{GS} = 0 \text{ V}, \text{ f} = 1 \text{ MHz}$		1375		
Reverse Transfer Capacitance	C _{rss}			83		
T + 1 0 + 01	0	$V_{DS} = 50$ V, $V_{GS} = 10$ V, $I_{D} = 20$ A		47.5	72	
Total Gate Charge	Q _g			35.7	54	
Gate-Source Charge	Q _{gs}	V_{DS} = 50 V, V_{GS} = 7.5 V, I_D = 20 A		10.4		
Gate-Drain Charge	Q _{gd}			9.1		
Gate Resistance	Rg	f = 1 MHz	0.4	1.9	3.6	Ω
Turn-On Delay Time	t _{d(on)}			15	30	
Rise Time	t _r	V_{DD} = 50 V, R_L = 2.5 Ω		9	18	
Turn-Off Delay Time	t _{d(off)}	$\text{I}_\text{D} \cong$ 20 A, V_GEN = 10 V, R_g = 1 Ω		36	70	
Fall Time	t _f			10	20	
Turn-On Delay Time	t _{d(on)}			18	35	ns
Rise Time	t _r	V_{DD} = 50 V, R_L = 2.5 Ω		10	20	
Turn-Off Delay Time	t _{d(off)}	$\rm I_D \cong 20$ A, $\rm V_{GEN}$ = 7.5 V, $\rm R_g$ = 1 Ω		35	70	
Fall Time	t _f			10	20	
Drain-Source Body Diode Characteristic	cs					
Continuous Source-Drain Diode Current	ا _S	$T_{C} = 25 \ ^{\circ}C$			60	A
Pulse Diode Forward Current ^a	I _{SM}				100	A
Body Diode Voltage	V _{SD}	I _S = 5 A		0.77	1.1	V
Body Diode Reverse Recovery Time	t _{rr}			59	100	ns
Body Diode Reverse Recovery Charge	Q _{rr}	L = 20 A dl/dt = 100 A/va T = 05 °C		89	150	nC
Reverse Recovery Fall Time	t _a	I _F = 20 A, dl/dt = 100 A/μs, T _J = 25 °C		29		
everse Recovery Rise Time t _b				30		ns

Notes:

a. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 %.

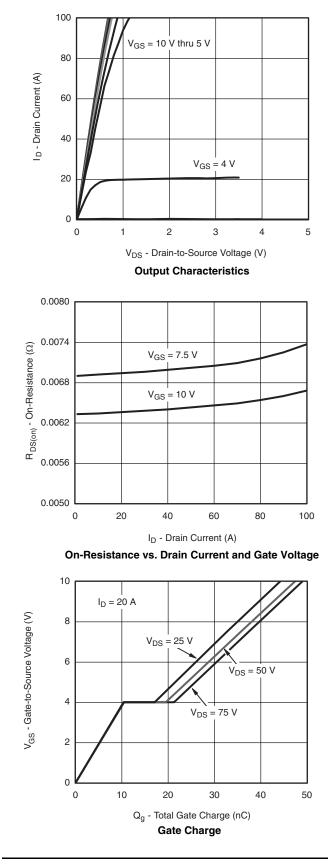
b. Guaranteed by design, not subject to production testing.

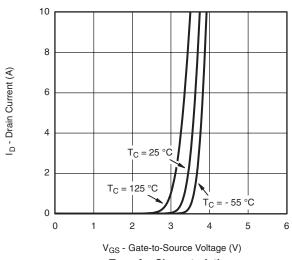
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



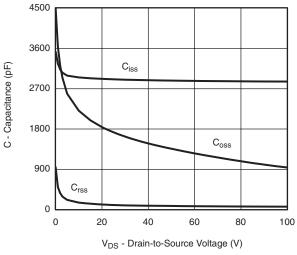
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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

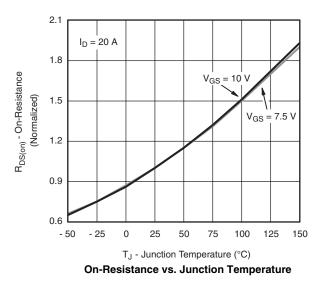




Transfer Characteristics



Capacitance

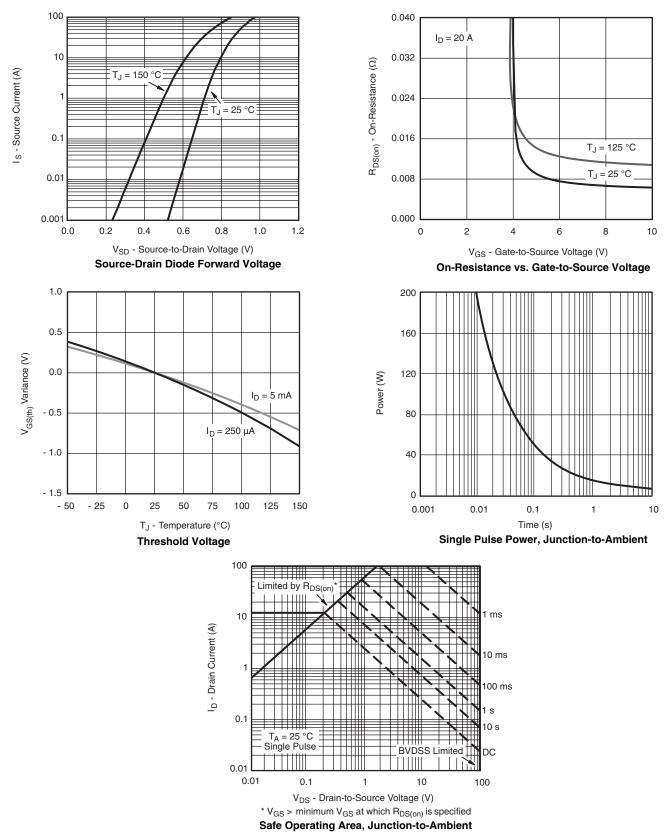


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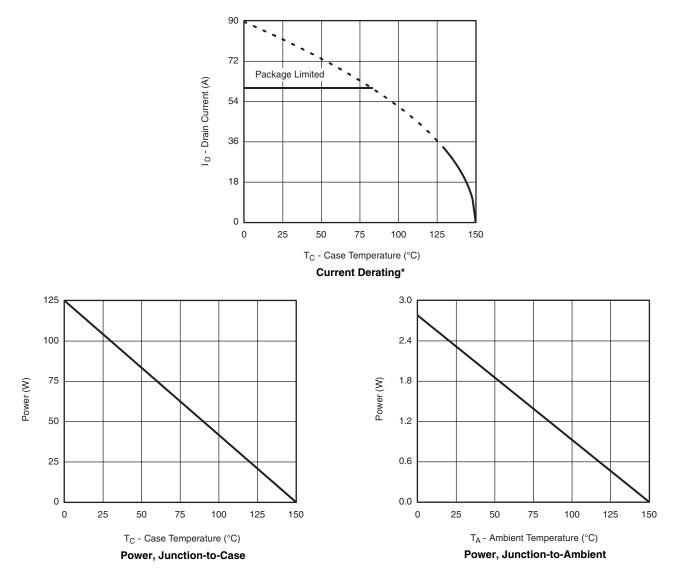
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SiR846DP Vishay Siliconix

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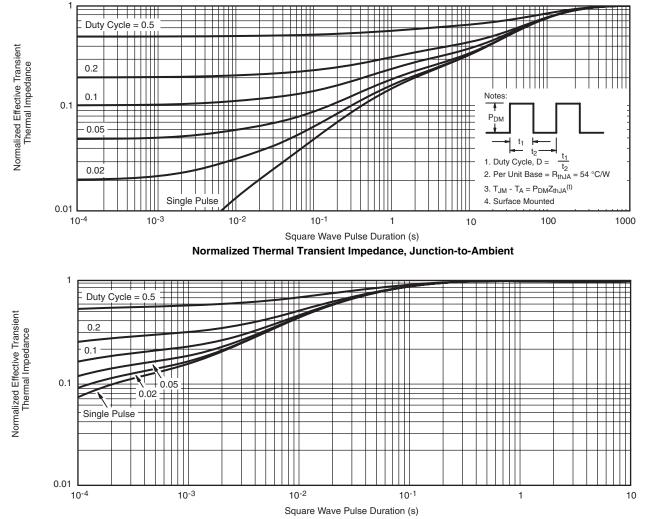


* The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Normalized Thermal Transient Impedance, Junction-to-Case

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see www.vishay.com/ppg265171.



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